

Specifications

HP 4142B Mainframe

Chassis

8 slots for plug-in measurement units.
No more than one HP 41425A Analog Feedback Unit per mainframe.
Maximum Common to Ground Voltage: $\pm 42V$.

Supported Plug-in Measurement Units

Model Number	Number of Slots Occupied	Range of Operation*
HP 41420A HPSMU	2	40 μ V to 200V, 20fA to 1A
HP 41421B MPSMU	1	40 μ V to 100V, 20fA to 100mA
HP 41422A HCU	2	40 μ V to 10V, 20nA to 10A
HP 41423A HVU	2	2mV to 1000V, 2pA to 10mA
HP 41424A VS/VMU	1	4 μ V to 40V, 20 μ A to 100mA
HP 41425A AFU	1	Used with two SMUs to make analog voltage/current searches

* 2000V max using two HVUs or 20A (pulsed) using two HCUs

Maximum Output Power

The sum of all measurement unit's instantaneous output power (product of Voltage Range and Current Output or Current Compliance) cannot exceed 32W. Each unit can be switched off to consume 0W power when in standby (power save) mode.

Unit	Instantaneous Output Power
HP 41420A HPSMU	$V_{range} \times I_O$ (or I_C) ¹
HP 41421B MPSMU	
HP 41422A HCU	$10W + 20V \times I_O$ (or I_C) x duty cycle ²
HP 41423A HVU	$10W + V_O$ (or V_C) x I_C (or I_O)
HP 41424A VS/VMU	2.2W (20V range) for each VS 0.88W (40V range) for each VS
HP 41425A AFU	0W
GNDU SMU	0W

V_O : V output set, V_C : V compliance, I_O : I output set, I_C : I compliance

¹2V range is calculated as 20V for the HP 41420A and HP 41421B

²Max pulse duty cycle: 1mA-1A range:10% 10A range:1%

Ground Unit (GNDU)

The GNDU is part of the HP 4142B mainframe. It is configured as a high current SMU set to 0 Volts. Used as measurement ground.

Connection:	0 Volt, Kelvin
Maximum offset voltage:	$\pm 500\mu V$
Current range:	$\pm 1.6A$
Maximum cable resistance	
FORCE terminal:	$\leq 1\Omega$
SENSE terminal:	$\leq 10\Omega$
Maximum capacitive load:	10 μ F

Control Unit (CTLU)

The control unit provides two functions. It controls the HP 16087A 3-input module selector, and provides a general purpose 16-bit TTL output (open collector) for extended system functions. Intended use of the TTL output is for external relay control and/or setting of test device internal settings.

Module Selector Relay Control Reference Data

Output voltage:	24V
Current limit:	30mA
Typical control speed:	30msec

16-Bit Relay Control Reference Data

Maximum voltage:	20V
Saturation voltage:	0.7V (at sink current = 50mA)
Pull-up voltage/resistor:	4.5V/10k Ω
Typical control speed:	10ms

Memory

The HP 4142B mainframe contains two types of memory which increase test speed. The program memory allows high-speed testing of multiple devices without the need to communicate over the HP-IB interface. The data memory collects and sends spot or swept data efficiently over the HP-IB interface.

Program memory: Stores approx. 2000 program steps, which can be grouped into 99 subroutines.

Data memory: Maximum of 4095 data values (binary)
Maximum of 1023 data values (ASCII)

Interfaces

External trigger input:	TTL level negative logic
Minimum pulse width:	100 μ sec
External trigger output:	TTL level negative logic
Approx pulse width:	100 μ sec
HP-IB interface:	SH1, AH1, T6, L4, SR1, RL1, PP0, DC1, DT1, C0, E1.

General Reference

Self-Test

At power-up the HP 4142B checks the operation of its own operational status. The self-test can be performed at any time via HP-IB.

Auto-Calibration

The offset errors in each measurement unit are automatically calibrated every 30 minutes.

Environmental Information

Operating temperature:	5°C to 40°C
Allowable temperature drift:	$\pm 3^\circ C$ (after auto-calibration)
Operating humidity:	5% to 80% RH
Storage temperature:	-40°C to 65°C
Storage humidity:	$\leq 90\%$ RH at 65°C
Operating inclination:	$\pm 20^\circ$ from horizontal

Power requirements

100/120/220V:	$\pm 10\%$
240V:	-10% to +5%
Maximum VA:	750 (48-66 Hz)

Dimensions

426mm W by 235mm H by 676mm D

Weight (approx.)

HP 4142B mainframe:	23kg	HP 41423A:	3kg
HP 41420A:	3kg	HP 41424A:	2kg
HP 41421B:	2kg	HP 41425A:	2kg
HP 41422A:	2kg		

Reference Data for HP 4142B

Recommended Computer

Consult the HP 4142B configuration, guide Lit. no 5091-0634E, for computers supported on each of the following three platforms:

- BASIC operating system on HP 9000 Series 300 workstations
- BASIC/UX operating system on HP 9000 Series 300 workstations
- BASIC/MS-DOS operating system on HP Vectra or IBM compatible PCs

Software

Included with the HP 4142B

Parameter Measurement Library: Resistance, MOS, and bipolar transistor algorithm sets

Test Instruction Set: Initialize, Force, Measure, Pulse, Sweep, Graphics, and Data Storage.

Additional software

HP IMA (Interactive Measurement and Analysis) WS, UX, or PC

HP ITG (Interactive Test Generator) WS, UX, or PC

HP IC-CAP (Integrated Circuit Characterization and Analysis Program) UX

Specifications

Typical Measurement Times

HP 9000 Series 332 computer.
ASCII data transfer time is included.

HP 41420A/HP 41421B SMU
(20V/100mA range, spot measurement)
Force I or V: 3.5msec
Measure I or V: 4.0msec

HP 41425A AFU
 V_T at $I_D = 1\mu\text{A}$: 12msec

HP-IB Data Transfer Rate
ASCII format: 1300 μsec /point
Binary format: 450 μsec /point

Measurement Accuracy

Is specified at front panel connector terminals, referenced to SMU common, under the following conditions:

1. 23 °C \pm 5 °C
2. 40 minute warm-up period
3. Auto Calibration enabled
4. Kelvin connection

HP 41420A High Power Source/Monitor Unit

The HP 41420A HPSMU occupies two slots in the HP 4142B mainframe. It sources voltage and monitors current, or sources current and monitors voltage. Separate FORCE and SENSE terminals enable Kelvin connections (remote sensing).

Output/Measurement Range, Resolution and Accuracy.

Voltage Range	Set. Resolution	Meas. Resolution	Accuracy	Maximum Current
$\pm 2\text{V}$	100 μV	40 μV	$\pm (0.05\% + 1\text{mV})$	$\pm 1\text{A}$
$\pm 20\text{V}$	1mV	400 μV	$\pm (0.05\% + 10\text{mV})$	$\pm 1\text{A}$ ($ V \leq 14\text{V}$) $\pm 0.7\text{A}$ ($ V > 14\text{V}$)
$\pm 40\text{V}$	2mV	800 μV	$\pm (0.05\% + 20\text{mV})$	$\pm 350\text{mA}$
$\pm 100\text{V}$	5mV	2mV	$\pm (0.05\% + 50\text{mV})$	$\pm 125\text{mA}$
$\pm 200\text{V}$	10mV	4mV	$\pm (0.05\% + 100\text{mV})$	$\pm 50\text{mA}$

Current Range	Set. Resolution	Meas. Resolution	Accuracy	Maximum Voltage
$\pm 1\text{nA}$	50fA	20fA	$\pm (1\% + 6\text{pA} + 20\text{fA} \times V_{\text{OUT}})$	$\pm 200\text{V}$
$\pm 10\text{nA}$	500fA	200fA	$\pm (1\% + 15\text{pA} + 200\text{fA} \times V_{\text{OUT}})$	
$\pm 100\text{nA}$	5pA	2pA	$\pm (0.5\% + 100\text{pA} + 2\text{pA} \times V_{\text{OUT}})$	
$\pm 1\mu\text{A}$	50pA	20pA	$\pm (0.5\% + 1\text{nA} + 20\text{pA} \times V_{\text{OUT}})$	
$\pm 10\mu\text{A}$	500pA	200pA	$\pm (0.2\% + 10\text{nA} + 200\text{pA} \times V_{\text{OUT}})$	
$\pm 100\mu\text{A}$	5nA	2nA	$\pm (0.2\% + 100\text{nA} + 2\text{nA} \times V_{\text{OUT}})$	
$\pm 1\text{mA}$	50nA	20nA	$\pm (0.2\% + 1\mu\text{A} + 20\text{nA} \times V_{\text{OUT}})$	
$\pm 10\text{mA}$	500nA	200nA	$\pm (0.2\% + 10\mu\text{A} + 200\text{nA} \times V_{\text{OUT}})$	
$\pm 100\text{mA}$	5 μA	2 μA	$\pm (0.2\% + 100\mu\text{A} + 2\mu\text{A} \times V_{\text{OUT}})$	
$\pm 1\text{A}$	50 μA	20 μA	$\pm (0.5\% + 1\text{mA} + 20\mu\text{A} \times V_{\text{OUT}})$	
			$\pm 200\text{V}$ ($ I \leq 50\text{mA}$) $\pm 100\text{V}$ ($ I > 50\text{mA}$)	
			$\pm 40\text{V}$ ($350\text{mA} \geq I > 50\text{mA}$) $> 125\text{mA}$) $\pm 20\text{V}$ ($0.7\text{A} \geq I > 350\text{mA}$) $> 350\text{mA}$) $\pm 14\text{V}$ ($ I > 0.7\text{A}$)	

Note: V_{OUT} is the SMU output voltage in volts.

Voltage/Current Compliance

The SMU can limit output voltage or current to prevent damage to a device under test.

Compliance voltage and current resolutions are the same as the Setting Resolutions in the table above, however the maximum compliance current resolution is 1pA. The Accuracy specifications, listed in the above table, apply also to the accuracy of compliance settings.

Current Over-range

1nA–100mA range: 15% of range
1A range: 0%

Reference Data for HP 41420A

Maximum capacitive load: 1000pF
Maximum guard capacitance: 900pF
Maximum shield capacitance: 5000pF
Maximum cable resistance
FORCE terminal: 10 Ω (100mA)
0.7 Ω (1A)
SENSE terminal: 10 Ω

Typical voltage source output resistance/current measurement input resistance (non-Kelvin connection): 0.2 Ω

Typical voltage measurement input resistance/current source output resistance: $\geq 10^{12}\Omega$
Guard offset voltage: $\pm 1\text{mV}$

Noise (typical)
(20V range, 10 μA or above)
Voltage source: 0.005% of V range (rms)
Current source: 0.005% of I range (rms)
Voltage monitor: 0.01% of V range (p-p)
Current monitor: 0.05% of I range (p-p)

Output overshoot (typical)
Voltage source: 0.03% of V range
Current source: 0.03% of I range

Typical range switching transient noise
Voltage ranging: 250mV
Current ranging: 10mV
Maximum slew rate: 2V/ μsec

HP 41421B Medium Power Source/Monitor Unit

The HP 41421B MPSMU requires one slot in the HP 4142B mainframe. It sources voltage and monitors current, or sources current and monitors voltage. Separate FORCE and SENSE terminals enable Kelvin connections (remote sensing).

Output/Measurement Range, Resolution and Accuracy.

Voltage Range	Set. Resolution	Meas. Resolution	Accuracy	Maximum Current
$\pm 2\text{V}$	100 μV	40 μV	$\pm (0.05\% + 1\text{mV})$	$\pm 100\text{mA}$
$\pm 20\text{V}$	1mV	400 μV	$\pm (0.05\% + 10\text{mV})$	
$\pm 40\text{V}$	2mV	800 μV	$\pm (0.05\% + 20\text{mV})$	
$\pm 100\text{V}$	5mV	2mV	$\pm (0.05\% + 50\text{mV})$	

Current Range	Set. Resolution	Meas. Resolution	Accuracy	Maximum Voltage
$\pm 1\text{nA}$	50fA	20fA	$\pm (1\% + 6\text{pA} + 20\text{fA} \times V_{\text{OUT}})$	$\pm 100\text{V}$
$\pm 10\text{nA}$	500fA	200fA	$\pm (1\% + 15\text{pA} + 200\text{fA} \times V_{\text{OUT}})$	
$\pm 100\text{nA}$	5pA	2pA	$\pm (0.5\% + 100\text{pA} + 2\text{pA} \times V_{\text{OUT}})$	
$\pm 1\mu\text{A}$	50pA	20pA	$\pm (0.5\% + 1\text{nA} + 20\text{pA} \times V_{\text{OUT}})$	
$\pm 10\mu\text{A}$	500pA	200pA	$\pm (0.2\% + 10\text{nA} + 200\text{pA} \times V_{\text{OUT}})$	
$\pm 100\mu\text{A}$	5nA	2nA	$\pm (0.2\% + 100\text{nA} + 2\text{nA} \times V_{\text{OUT}})$	
$\pm 1\text{mA}$	50nA	20nA	$\pm (0.2\% + 1\mu\text{A} + 20\text{nA} \times V_{\text{OUT}})$	
$\pm 10\text{mA}$	500nA	200nA	$\pm (0.2\% + 10\mu\text{A} + 200\text{nA} \times V_{\text{OUT}})$	
$\pm 100\text{mA}$	5 μA	2 μA	$\pm (0.2\% + 100\mu\text{A} + 2\mu\text{A} \times V_{\text{OUT}})$	
			$\pm 100\text{V}$ ($ I \leq 20\text{mA}$) $\pm 40\text{V}$ ($50\text{mA} \geq I > 20\text{mA}$) $> 20\text{mA}$) $\pm 20\text{V}$ ($ I > 50\text{mA}$)	

Note: V_{OUT} is the SMU output voltage in volts.

Specifications

Voltage/Current Compliance

Same as the HP 41420A HPSMU

Current Over-range

1nA–10mA range: 15% of range
100mA range: 0%

Reference Data for HP 41421B

Same as the HP 41420A HPSMU

HP 41422A High Current Source/Monitor Unit

The HP 41422A HCU occupies two slots and operates in pulse mode only. It sources voltage and monitors current, or sources current and monitors voltage. Separate FORCE and SENSE terminals enable Kelvin connections (remote sensing).

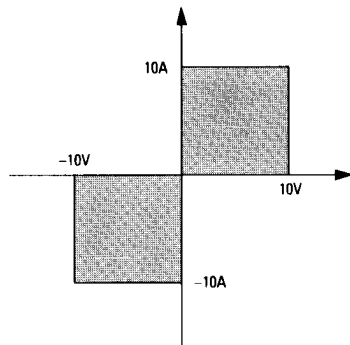
Output/Measurement Range, Resolution and Accuracy. (PULSE ONLY)

Voltage Range	Set. Resolution	Meas. Resolution	Accuracy	Maximum Current
± 2V	200µV	40µV	± (0.5% + 10mV)	± 10A (Unipolar)
± 20V (± 10V max.)	2mV	400µV	± (0.5% + 100mV)	

Current Range	Set. Resolution	Meas. Resolution	Accuracy	Maximum Voltage
± 1mA	100nA	20nA	± (0.5% + 2µA + 100nA × V _{OUT})	± 10V (Unipolar)
± 10mA	1µA	200nA	± (0.5% + 20µA + 1µA × V _{OUT})	
± 100mA	10µA	2µA	± (0.5% + 200µA + 10µA × V _{OUT})	
± 1A	100µA	20µA	± (1% + 2mA + 100µA × V _{OUT})	
± 10A	1mA	200µA	± (2% + 20mA + 1mA × V _{OUT})	

Note: V_{OUT} is the HCU output voltage in volts.
Pulse is unipolar (voltage and current are the same polarity).
Pulse base value is fixed to 0 volts.

HCU Output and Measurement Range



Voltage/Current Compliance

The HCU can limit output voltage or current to prevent damage to a device under test. Compliance voltage and current resolutions are the same as the Setting Resolutions in the table above, however the maximum compliance current resolution is 1µA. The Accuracy specifications, listed in the above table, apply also to the accuracy of compliance settings.

Current Over-range

1mA–1A range: 15% of range
10A range: 0%

Pulse Settings and Accuracy

Single pulse width: 100µsec–1msec
(100µs resolution)
Dual pulse width: 100µsec–800µsec
(100µs resolution)
Maximum pulse duty cycle:
1mA–1A range: 10%
10A range: 1%
Maximum pulse power: 100mJ

Hold time accuracy: 0.5% ± 1msec
Delay time accuracy: 0.5% ± 1msec
Pulse period accuracy: 0.5% ± 100µsec
Pulse width accuracy: 0.5% ± 20µsec

Reference Data for HP 41422A

Maximum capacitive load: 3.5nF
Maximum inductive load: 1µH on 10A range
Maximum cable resistance
FORCE terminal: 150mΩ @ 10V, 10A
SENSE terminal: 10Ω
Maximum cable inductance
FORCE terminal: 200nH max
Noise (typical)
Voltage source: 0.01% of V range (rms)
Current source: 0.1% of I range (rms)
Voltage monitor: 0.02% of V range (p-p)
Current monitor: 0.2% of I range (p-p)
Maximum slew rate: 0.3V/µsec

HP 41423A High Voltage Source/Monitor Unit

The HP 41423A HVU occupies two slots in the HP 4142B mainframe. It sources voltage and monitors current, or sources current and monitors voltage.

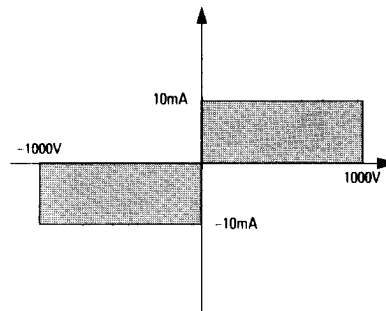
Output/Measurement Range, Resolution and Accuracy.

Voltage Range	Set. Resolution	Meas. Resolution	Accuracy	Maximum Current
± 100V	10mV	2mV	± (0.5% + 0.5V)	± 10mA (Unipolar)
± 200V	20mV	4mV	± (0.5% + 1V)	
± 500V	50mV	10mV	± (0.5% + 2.5V)	
± 1000V	100mV	20mV	± (0.5% + 5V)	

Current Range	Set. Resolution	Meas. Resolution	Accuracy	Maximum Voltage
± 100nA	50pA	2pA	± (1% + 1nA)	± 1000V (Unipolar)
± 1µA	500pA	20pA	± (1% + 10nA)	
± 10µA	5nA	200pA	± (1% + 100nA)	
± 100µA	50nA	2nA	± (1% + 1µA)	
± 1mA	500nA	20nA	± (1% + 10µA)	
± 10mA	5µA	200nA	± (1% + 100µA)	

Note: Unipolar output means non-zero crossing.
In pulse mode the output may be offset with a base value.

HVU Output and Measurement Range



Voltage/Current Compliance

The HVU can limit output voltage or current to prevent damage to a device under test.

Compliance voltage and current resolutions are the same as the Setting Resolutions in the table above, however the maximum compliance current resolution is 2pA. The Accuracy specifications, listed in the above table, apply also to the accuracy of compliance settings.

Specifications

Reference Data for HP 41423A

Maximum capacitive load:	1000pF
Maximum guard capacitance:	300pF
Maximum shield capacitance:	800pF
Typical output resistance:	0.2 Ω
Guard offset voltage:	± 1 mV
Noise (typical)	
Voltage source:	0.01% of V range (rms)
Current source:	0.1% of I range (rms)
Voltage monitor:	0.02% of V range (p-p)
Current monitor:	1% of I range (p-p)
Change polarity time:	100msec
Channel off/on time:	100msec
Maximum slew rate:	12V/msec

HP 41424A Voltage Source/Voltage Monitor Unit

The HP 41424A VS/VMU provides two voltage monitors and two voltage supplies with built-in ammeters. The voltage monitors can be connected in a differential measurement configuration for improved resolution. This module occupies a single slot.

Voltage Source Output/Measurement Range, Resolution and Accuracy.

Voltage Range	Set Resolution	Accuracy	Maximum Current
± 20 V	1mV	$\pm (0.1\% + 10$ mV)	100mA
± 40 V	2mV	$\pm (0.1\% + 20$ mV)	20mA

Current Range	Meas. Resolution	Accuracy
± 20 mA	20 μ A	$\pm (3\% + 200$ μ A)
± 100 mA	100 μ A	$\pm (3\% + 1$ mA)

Voltage Monitor Range, Resolution and Accuracy

Voltage Range	Meas. Resolution	Accuracy
± 2 V	40 μ V	$\pm (0.05\% + 1$ mV)
± 20 V	400 μ V	$\pm (0.05\% + 10$ mV)
± 40 V	800 μ V	$\pm (0.05\% + 20$ mV)

Differential Voltage Monitor Range, Resolution and Accuracy

Voltage Range	Meas. Resolution	Accuracy	Max. Common Voltage
± 0.2 V	4 μ V	$\pm (0.2\% + 0.4$ mV + 2.5μ V $\times V_{IN}$)	± 40 V
± 2 V	40 μ V	$\pm (0.2\% + 2$ mV + 25μ V $\times V_{IN}$)	

Note: V_{IN} is the VM input voltage (common mode) in volts.

Voltage/Current Compliance

The VS has a current limiter. The limiter value is automatically determined by the output voltage range. If the output range is 20V, the current limit is 100mA. If the output range is 40V, the current limit is 20mA.

Reference Data for HP 41424A

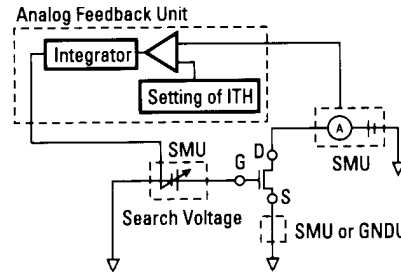
VS typical output resistance:	0.2 Ω
VS maximum capacitive load:	10 μ F
VS maximum slew rate:	0.2V/ μ sec
VS current limit accuracy:	- 0%, + 10%
VS typical output noise:	0.005% of V range (rms)

VM typical input resistance:	≥ 100 M Ω
VM maximum leakage current (@ 0V):	2nA
VM typical noise level at input:	0.01% of V range (p-p)

DVM typical differential measurement noise:	0.02% of V range (p-p)
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HP 41425A Analog Feedback Unit

The HP 41425A AFU searches for a target current or voltage on one SMU by controlling (sweeping) the output voltage of another SMU. It requires one slot and two SMUs. Only one AFU can be used per HP 4142B mainframe. SMUs may be either the HP 41420A HPSMU or HP 41421B MPSMU. The analog search capability of the AFU reduces the time required for measurements like h_{FE} or V_{th} , which would otherwise require a more lengthy binary search technique.



Reference Data for HP 41425A

Monitor Specifications

Range and resolution:	Same as SMU's.
Setting accuracy:	SMU's accuracy + 0.1% of value + 0.1% of range.
Monitor accuracy:	Same as SMU's.
Overrange:	0%
Maximum target voltage:	180V (HP 41420A HPSMU) 90V (HP 41421B MPSMU) 900mA (HP 41420A HPSMU) 90mA (HP 41421B MPSMU)
Maximum current:	

Search Specifications

Voltage ranges:	2V, 20V, 40V, 100V, or 200V (HP 41420A only)
Slew rates:	0.5mV/ms to 1000V/ms in decade steps
Slew rate resolution:	1/100 of slew rate range
Slew rate accuracy:	35% of setting + 5% of range
Start voltage accuracy:	0.5% of setting + 0.5% of voltage range
Stop voltage accuracy:	3% of voltage range
Ramp stop delay time:	5 μ sec (typically)

HP 16087A Module Selector

The HP 16087A module selector is a 3-input scanner which allows remote control of the connection of an SMU, HCU, or HVU to a single DUT pin. Only one module selector per HP 4142B mainframe is allowed. It may be used by itself or as a built-in option of the 16088B test fixture.

Input Channels

Channel Type	Number of Channels	Connection
SMU (HP 41420A/41421B)	1	Kelvin
HCU (HP 41422A)	1	Kelvin
HVU (HP 41423A)	1	Non-Kelvin

Allowable Voltage and Current

Channel	Max Voltage	Max Current
SMU	200V	1A
HCU	10V	10A
HVU	1000V	10mA

Specifications

SMU Channel Reference Data

Maximum leakage current	
FORCE (or SENSE) to COM:	15pA @ 200V
Maximum stray capacitance	
FORCE (or SENSE) to COM:	15pF
FORCE (or SENSE) to other SMU:	3pF
Maximum guard capacitance	
FORCE (or SENSE) to guard:	60pF
Typical residual resistance	
FORCE:	200mΩ
Minimum channel off resistance:	100GΩ

HCU Channel Reference Data

Maximum leakage current	
Hi FORCE to Lo FORCE:	1nA @ 10V
Hi SENSE to Lo SENSE:	1nA @ 10V
Maximum stray capacitance	
Hi FORCE to Lo FORCE:	400pF
Hi SENSE to Lo SENSE:	200pF
Typical residual resistance	
FORCE (Hi + Lo)	95mΩ
Minimum channel off resistance:	100GΩ

HVU Channel Reference Data

Maximum leakage current	
FORCE to COM:	15pA @ 200V
Maximum stray capacitance	
FORCE to COM:	15pF
FORCE to other SMU:	3pF
Maximum guard capacitance	
FORCE to guard:	30pF
Typical residual resistance:	400mΩ
Minimum channel off resistance:	100GΩ

HP 16088B Test Fixture

The HP 16088B is a 13-channel fixture designed to test packaged parts over the entire measurement range of the HP 4142B. Option 300 adds a built-in HP 16087A module selector.

Input Channels

Channel Type	Number of Channels	Connection
SMU (HP 41420A/41421B)	4	Kelvin (8; Non-Kelvin)
HCU (HP 41422A)	2	Kelvin
HVU (HP 41423A)	2	Non-Kelvin
VS (HP 41424A)	2	Non-Kelvin
VMU (HP 41424A)	2	Non-Kelvin
GNDU	1	Kelvin

Allowable Voltage and Current

Channel	Max Voltage	Max Current
SMU	200V	1A
HCU	10V	10A
HVU	1000V	10mA
VS	40V	100mA
VMU	40V	—
GNDU	—	1.6A

SMU Channel Reference Data

Maximum leakage current	
FORCE (or SENSE) to COM:	10pA @ 200V
Maximum stray capacitance	
FORCE (or SENSE) to COM:	15pF
FORCE (or SENSE) to other SMU:	3pF
Maximum guard capacitance	
FORCE (or SENSE) to guard:	70pF
Typical residual resistance	
FORCE:	60mΩ (300mΩ with opt 300)

HCU Channel Reference Data

Maximum leakage current	
Hi FORCE to Lo FORCE:	1nA @ 10V
Hi SENSE to Lo SENSE:	1nA @ 10V
Maximum stray capacitance	
Hi FORCE to Lo FORCE:	300pF
Hi SENSE to Lo SENSE:	100pF
Typical residual resistance	
FORCE (Hi + Lo):	70mΩ (105mΩ with opt 300)

HVU Channel Reference Data

Maximum leakage current	
FORCE to COM:	10pA @ 200V
Maximum stray capacitance	
FORCE to COM:	15pF
FORCE to other SMU:	3pF
Maximum guard capacitance	
FORCE to guard:	40pF (60pF with opt 300)
Typical residual resistance:	300mΩ (500mΩ with opt 300)

VS/VMU Channel Reference Data

Typical residual resistance:	70mΩ
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GNDU Channel reference Data

Typical residual resistance	
FORCE or SENSE:	40mΩ

HP 16276B/16277B/16278B

Interactive Measurement and Analysis (IMA) Software

The HP IMA software turns the HP 4142B into a full feature parameter analyzer. Software compatibility is maintained to allow HP 4145B test programs to run on the HP 4142B.

Computers operating on three platforms are supported.

HP 16276B IMA/WS

BASIC operating system on HP 9000 Series 300 workstations

HP 16277B IMA/UX

BASIC/UX operating system on HP 9000 Series 300 workstations

HP 16278B IMA/PC

BASIC/MS-DOS operating system on HP Vectra or IBM AT compatible PCs. Requires an HP measurement coprocessor card with at least 4M bytes of memory.

Consult the HP 4142B configuration guide, Literature number 5091-0634E, for details of supported controllers, peripherals, and operating system software revisions.

Basic Functions

- Sets the HP 4142B measurement parameters
- Measurement control
- Arithmetic calculations
- Displays measurement and calculation results
- Graphical analysis
- Printer and plotter hard copy support
- HP BASIC programming environment for automatic measurement and analysis
- Stores and recalls measurement setups and measurement data
- Performs calibration of the HP 4142B

Number of HP 4142B mainframes supported: 1

Number of total HP 4142B units supported: 8 (16 VS/VMU channels)

HP 4142B units supported

- HP 41420A High Power Source/Monitor Unit (HPSMU)
- HP 41421B Medium Power Source/Monitor Unit (MPSMU)
- HP 41422A High Current Unit (HCU)
- HP 41423A High Voltage Unit (HVU)
- HP 41424A V Source/V Monitor Unit (VS/VMU)

Specifications

HP 16087A Control Unit (3-input scanner and 16-bit TTL output)
HP 4142B Ground Unit (GNDU)

The HP 41425A (AFU) is not supported.

Measurement Control

VAR1 Sweep

The main sweep. Voltage or current sourcing is controllable over the full range of each supported HP 4142B unit.

Max number of steps:	1001
Max number of data points:	4004, 8008 including VAR1'
Sweep modes:	Linear or logarithmic Single or double staircase
Sweep parameters:	START, STEP, No. of STEPS
Hold time:	0 to 655.35 seconds with 10ms resolution
Delay time:	0 to 65.535 seconds with 1ms resolution

VAR1' Sweep

Staircase sweep of a second unit which can be slaved to the first. The sweep is made with a user specified fixed ratio and offset value.

VAR1' output is calculated as:

$$\text{VAR1}'(\text{Start}) = a \times \text{VAR1}(\text{Start}) + b$$

$$\text{VAR1}'(\text{Stop}) = a \times \text{VAR1}(\text{Stop}) + b$$

where a is the user-specified ratio and b is the user specified offset value.

VAR2 Sweep

A subordinate linear staircase or pulsed sweep. The VAR2 unit output is incremented one STEP each time the VAR1 units completes one sweep.

Sweep parameters:	START, STEP, No. of STEPS
Max number of steps:	32

Pulse modes supported*

Single channel:	Measurement limited to one channel.
Dual channel:	Two channels can be synchronously pulse. One channel must be an HCU. Measurement limited to one channel.
quasi-pulse:	SMU or HVU channel can be ramped until its slew rate abruptly changes. Useful for making quick and safe breakdown or leakage measurements.

*Pulse is not selectable when VAR1' is set.

Time Domain

Time domain is selectable when VAR1 is not set. VAR1 sweep is replaced by time sweep.

Wait Time:	0 to 100 seconds with 50ms resolution (Initial wait time or wait time after VAR2 step)
Interval:	50ms to 100 seconds with 50ms resolution (Interval between measurements)

Display Modes

Graphics:	Two axes (X-Y1) or three axes (X-Y1,Y2) plot of source, measurement, time, or USER FUNCTION calculations.
List:	Used in conjunction with VAR1 or TIME sweep. Up to six measurement parameters and USER FUNCTION results can be displayed for each step of VAR1.

Arithmetic and Analysis Functions

Arithmetic Functions

Arithmetic expressions can be used in USER FUNCTIONS and user DISPLAY functions. Each expression can contain a maximum of 80 characters.

User Functions

Up to four USER FUNCTIONS can be defined as arithmetic expressions. USER FUNCTIONS are executed during the measurement and the results displayed with measurement results.

Display Functions

Up to two user DISPLAY FUNCTIONS can be defined as arithmetic expressions. These functions are executed in conjunction with the Marker, Cursor, or line operations to get direct output of parameters such as V_T , GM_{MAX} , R_{DS} , etc.

The following graphic analysis parameters may be used in the DISPLAY FUNCTIONS:

- Marker position
- Cursor position
- Line gradient
- Line intersect to axis
- Intersect of two lines
- Regression coefficient of REGRESSION function

Arithmetic Operators

USER and DISPLAY functions may use the following operators:

+ , - , × , / , SQRT(square root), EXP(Napierian constant), LOG (natural log), LGT (common log), ^ (exponentiation), ABS(absolute value), SGN(sign), DELTA (differential calculation), FRACT(fractional), Trigonometric functions (SIN,COS,TAN,ASN,ACS,ATN), and E (scientific notation).

Graphical Analysis Functions

Marker functions

Interpolation: × 10 resolution between measurement data points

→min or →max: Moves marker to minimum or maximum data point

Direct: Finds closest data point to user specified value

Mouse control: Finds closest data point to user mouse click

Cursor functions

Cursor→Marker: Moves cursor to the marker position

Mouse control: Cursor follows point where mouse is clicked

Line functions

Regression: Draws a line calculated by the least squares fit method around the marker. Linear scale only.

Tangent: Draws a tangent line to a curve at the marker.

Line: Draws a line between the marker and cursor.

Scaling functions

Auto: Graphics automatically resized for optimum display of measurement results.

Move: Reposition the display with cursor at center.

Zoom: Draw a box in the graphics area and expand the box to full scale. May be repeated.

Reset: Resets and moves graphics to original state.

Buffer functions

Buffer 1: Buffer 1 is the working graphics buffer. Analysis is done here.

Buffers 2-4: Stores three additional sets of graphs.

Recall: Allows overlaying of buffer contents for comparison of similar measurements.

Exchange: Exchanges contents between buffer 1 and buffer 2,3, or 4.

HP 4145B Data Compatibility

The measurement setup and data taken by the HP 4145B is fully compatible with the HP IMA software (except for files containing schmo, or matrix display, and the ASP file).

Analysis Instruction Set (AIS)

Over 40 subprograms are provided so that all of the capabilities of HP IMA interactive mode may be automated for hands-off data gathering and analysis. AIS subprograms are linked to the HP BASIC programming environment. This allows other instrument control or user interface code to be added for complete turnkey test solutions.

Ordering Information



For complete ordering information, please see the HP 4142B Modular DC Source/Monitor configuration guide (HP literature number 5091-0634E). It suggests application specific ordering examples, including recommended controllers, optional software, cabling, connectors, fixtures, other accessories and support services.

HP 4142B Modular DC Source/Monitor

Ground Unit

Safety Interlock

8 slots for plug-in measurement modules

Mainframe Options

Opt. 050 50Hz Line Frequency

Opt. 060 60Hz Line Frequency

Opt. 100 100/120V Line Voltage

Opt. 220 220/240V Line Voltage

Opt. 300 Control unit*

Measurement Module Options

Opt. 400 HP 41420A HPSMU:200V,1A (2 slots)

Opt. 410 HP 41421B MPSMU:100V,100mA (1 slot)

Opt. 420 HP 41422A HCU:10V,10A (2 slots)

Opt. 430 HP 41423A HVU:1000V,10mA (2 slots)

Opt. 440 HP 41424A VS/VMU:40V,100mA (1 slot)

Opt. 450 HP 41425A AFU (1 slot)

*Required with HP 16087A and HP 16088B opt 300.

Accessories

HP 16058A Test Fixture (Non-Kelvin SMU, VS/VMU)
Includes set of 4 triax cables (1.5m)

Opt. 001 Adds HP 4142B system cable

HP 16087A Module Selector (supports SMU, HCU, HVU)
(Includes connector plate and on/off status indicator)

HP 16088B Test Fixture (Kelvin, supports all HP 4142B plug-in units)
Opt. 010 Socket module set for power devices
Opt. 020 Socket module set for small signal devices
Opt. 030 Universal socket module for custom devices
Opt. 300 Adds module selector (mounted inside fixture)

HP 4142B Application Notes

- AN 356 High Speed DC Characterization of Semiconductor Devices from Sub pA to 1A
- AN 356-1 Techniques and Applications for High Throughput and Stable Characterization
- AN 383-1 Simplification of DC Characterization and Analysis of Semiconductor Devices (HP IMA measurement examples)
- AN 383-2 Automation of DC Characterization and Analysis of Semiconductor Devices (HP IMA programming examples)
- AN 1205 Efficient Microwave Bias and Test Using the HP 4142B Modular DC Source/Monitor

HP 4142B Product Notes

- PN 4142B-1 DC Characterization of Power Devices; Practical Applications Using the HP 4142B Modular DC Source/Monitor

For more information, call your local HP sales office listed in your telephone directory or an HP regional office listed below for the location of your nearest sales office.

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4 Choke Cherry Road
Rockville, MD 20850
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Hewlett-Packard Company
5201 Tollview Drive
Rolling Meadows, IL 60008
(708) 255-9800

Hewlett-Packard Company
5161 Lankershim Blvd.
No. Hollywood, CA 91601
(818) 505-5600

Hewlett-Packard Company
2015 South Park Place
Atlanta, GA 30339
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